

Reference Standards for Conductivity and Coating Thickness Measurement



ELOTES M2 V3



ELOTES M3



ELOTES B300

Our hand-held **ELOTES Eddy Current Test Instruments M2 V3, M3 and the B300-series** offer additionally to the standard eddy current functions the possibility to measure conductivity and coating thickness. For this all instruments use the standard test frequency of 60 kHz. The conductivity measuring can be carried out in % IACS as well as in MS/m. The measuring range extends from 1 % IACS to 110 % IACS and is suitable for the conductivity measurement of non-ferromagnetic metals and metal alloys. The layer thickness measuring can be carried out in μm or in mil and is suitable for the measuring of non-conductive layers up to 1000 μm on conductive, but non-ferromagnetic basic material.



Probe KAS-7 H-190
Standard probe for conductivity measurement at 60 kHz in straight design



Probe with prism guiding KAS-7 H-190.03.1
Angled standard probe for conductivity measurement at 60 kHz



Cable EK-2-023
Connecting cable for standard conductivity probes for ELOTES M2 V3, M3 or B300. ELOTES B300 requires a B3-RS adaptor.



Reference standard TP 79.02.1
Conductivity standard



Reference standard TP79.04.1
Conductivity standard



Reference standard TP 105 aluminium
Coating thickness standard

Conductivity measuring

Description	Item-No.	Content	Material
TP 79.02.1	A0M0020079001021	with reference parts CU-E/ approx. 101 % IACS TiAl6V4/ 3.7165/ approx. 1 % IACS	Copper inlet Titanium inlet
TP 79.04.1	A0M0020079001041	with 6 reference parts CU-E/ approx. 101 % IACS TiAl6V4/ 3.7165/ approx. 1 % IACS 1.4305/ approx. 3 % IACS CuZn3Pb3/ Ms 58/ approx. 28 % IACS AlMg1/ 3.3315/ approx. 33 % IACS AlCuMgPb/ 3.1645/ approx. 46 % IACS	Copper inlet Titanium inlet Stainless steel inlet Brass inlet Aluminium inlet Aluminium inlet
TP 79.05.1	A0M0020079001051	with 3 reference parts AlMg1/ 3.3315/ approx. 33 % IACS AlCuMgPb/ 3.1645/ approx. 46 % IACS Al99,5/ 3.0255/ approx. 59 % IACS	Aluminium inlet Aluminium inlet Aluminium inlet

Layer thickness

Description	Item-No.	Content	Material
TP105	A0M0020105001011	Aluminium carrier plate, 50x100mm Foilcalibration standard Foilcalibration standard Foilcalibration standard Foilcalibration standard	50 µm 100 µm 500 µm 1000 µm

Probes for conductivity and layer thickness

Description	Item-No.	Test frequency
KAS-7 H-190 (straight design)	A0M0010190001011	60 kHz / straight design (probe 200 Hz - 100 kHz)
KAS-7 H190.03.1 (angled design)	A0M0010190001031	60 kHz / 90° angled design (probe 200 Hz - 100 kHz)

Probe cable

Description	Item-No.	
EK-2-023	A0MW100000023011	Cable for both KAS-probes for M2 V3, M3 and B300. B300 requires the B3-RS adaptor.